



Product data sheet

www.msksemi.com

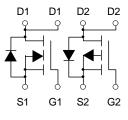
Downloaded From Oneyac.com







SOP-8



N-Channel and P-Channel

Description

The AO4614-MS uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

General Features

V_{DS} = 40V I_D =7.2A

 $R_{DS(ON)} < 26m\Omega @ V_{GS}=10V$

 $V_{DS} = -40V I_D = 6.5A$

 $R_{DS(ON)} < 54m\Omega @ V_{GS}=10V$

Application

Battery protection

Load switch Uninterruptible power supply

Absolute Maximum Ratings (Tc=25°C unless otherwise noted)

		Rating			
Symbol	Parameter	N-Ch	P-Ch	Units	
Vds	Drain-Source Voltage	40	-40	V	
Vgs	Gate-Source Voltage	±20	±20	V	
I _D @T _A =25°C	Continuous Drain Current, V _{GS} @ 10V ¹	7.2	-6.5	А	
I₀@T₄=70°C	Continuous Drain Current, V _{GS} @ 10V ¹	5.6	-5.1	А	
Ідм	Pulsed Drain Current ²	23	-22	А	
EAS	Single Pulse Avalanche Energy ³	16.2	39	mJ	
las	Avalanche Current	18	-28	А	
P _D @T _A =25°C	Total Power Dissipation ⁴	1.67	1.67	W	
Тѕтс	Storage Temperature Range	-55 to 150	-55 to 150	°C	
TJ	Operating Junction Temperature Range	-55 to 150	-55 to 150	°C	
Reja	Thermal Resistance Junction-Ambient ¹	75	5	°C/W	
Rejc	Thermal Resistance Junction-Case ¹	30	30		



Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	40			V
BVDSS//TJ	BVDSS Temperature Coefficient	Reference to 25°C , I _D =1mA		0.034		V/°C
		V _{GS} =10V , I _D =5A		20	26	
RDS(ON)	Static Drain-Source On-Resistance ²	V _{GS} =4.5V , I _D =4A		28	33	mΩ
$V_{GS(th)}$	Gate Threshold Voltage		1.0		2.5	V
$V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	V _{GS} =V _{DS} , I _D =250uA		-4.56		mV/°C
		V _{DS} =32V , V _{GS} =0V , T _J =25°C			1	
ldss	Drain-Source Leakage Current	Vds=32V , Vgs=0V , Tj=55°C			5	uA uA
lgss	Gate-Source Leakage Current	$V_{GS}=\pm20V$, $V_{DS}=0V$			±100	nA
gfs	Forward Transconductance	V _{DS} =5V , I _D =5A		14		S
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		2.6		
Qg	Total Gate Charge (4.5V)			5.5		
Qgs	Gate-Source Charge			1.25		nC
Q _{gd}	Gate-Drain Charge			2.5		
Td(on)	Turn-On Delay Time			8.9		
Tr	Rise Time	V _{DD} =20V , V _{GS} =10V ,		2.2		
Td(off)	Turn-Off Delay Time	R _G =3.3 I _D =1A		41		ns
T _f	Fall Time			2.7		
Ciss	Input Capacitance			593		
Coss	Output Capacitance			76		pF
Crss	Reverse Transfer Capacitance			56		
ls	Continuous Source Current ^{1,5}	ontinuous Source Current ^{1,5}		6.1	А	
lsм	Pulsed Source Current ^{2,5}	−V _G =V _D =0V , Force Current			23	А
Vsd	Diode Forward Voltage ²	V _{GS} =0V , I _S =1A , T _J =25°C			1.2	V

N-Channel Electrical Characteristics (TJ=25 °C, unless otherwise noted)

Note :

1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.

2.The data tested by pulsed , pulse width $\leq 300 \text{us}$, duty cycle $\leq 2\%$

3. The EAS data shows Max. rating . The test condition is V_{DD} =25V, V_{GS} =10V, L=0.1mH, I_{AS}=18A

4.The power dissipation is limited by 150°C junction temperature

5 .The data is theoretically the same as I_{D} and I_{DM} , in real applications , should be limited by total power dissipation.

AO4614-MS HF 🐼

Compiance

Semiconductor



AO4614-MS	HF	RoHS

Semiconductor Compiance

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =-250uA				V
BVoss /Tj	BV _{DSS} Temperature Coefficient	Reference to 25°C,I⊵=-1mA		-0.02		V/°C
		V _{GS} =-10V , I _D =-6A		45	54	
RDS(ON)	Static Drain-Source On-Resistance ²	V _{GS} =-4.5V , I _D =-4A		80	85	mΩ
VGS(th)	Gate Threshold Voltage	V _{GS} =V _{DS} , I _D =-250uA	-1.0		-2.5	V
$V_{GS(th)}$	V _{GS(th)} Temperature Coefficient			3.72		mV/°C
		V _{DS} =-32V , V _{GS} =0V , T _J =25°C			1	
ldss	Drain-Source Leakage Current	V _{DS} =-32V , V _{GS} =0V , T _J =55°C			5	uA
Igss	Gate-Source Leakage Current	V _{GS} =±20V , V _{DS} =0V			±100	nA
gfs	Forward Transconductance	V _{DS} =-5V , I _D =-6A		13		S
Qg	Total Gate Charge (-4.5V)			11.5		
Qgs	Gate-Source Charge			3.5		nC
Q_{gd}	Gate-Drain Charge			3.3		
Td(on)	Turn-On Delay Time			22		
Tr	Rise Time			15.7		
Td(off)	Turn-Off Delay Time	I _D =-1A		59		ns
Tf	Fall Time			5.5		
Ciss	Input Capacitance			1415		
Coss	Output Capacitance	V _{DS} =-15V , V _{GS} =0V , f=1MHz		134		pF
Crss	Reverse Transfer Capacitance	_		102		
ls	Continuous Source Current ^{1,5}	V _G =V _D =0V , Force Current			-6	А
lsм	Pulsed Source Current ^{2,5}				-22	А
Vsd	Diode Forward Voltage ²	V _{GS} =0V , I _S =-1A , T _J =25°C			-1.2	V

Note :

1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.

2.The data tested by pulsed , pulse width $\,\leq\,$ 300us , duty cycle $\,\leq\,$ 2%

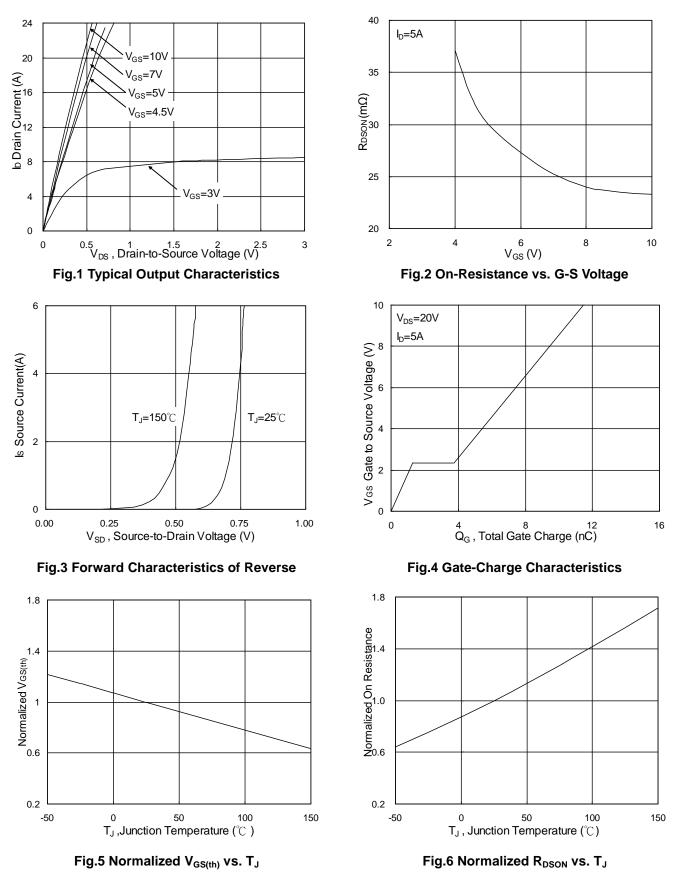
3. The EAS data shows Max. rating . The test condition is V_{DD} =-25V,V_{GS}=-10V,L=0.1mH,I_{AS}=-28A

4. The power dissipation is limited by 150 $^{\circ}$ C junction temperature 5. The data is theoretically the same as I_D and I_{DM}, in real applications, should be limited by total power dissipation.



AO4614-MS HF Compiance

N-Channel Typical Characteristics





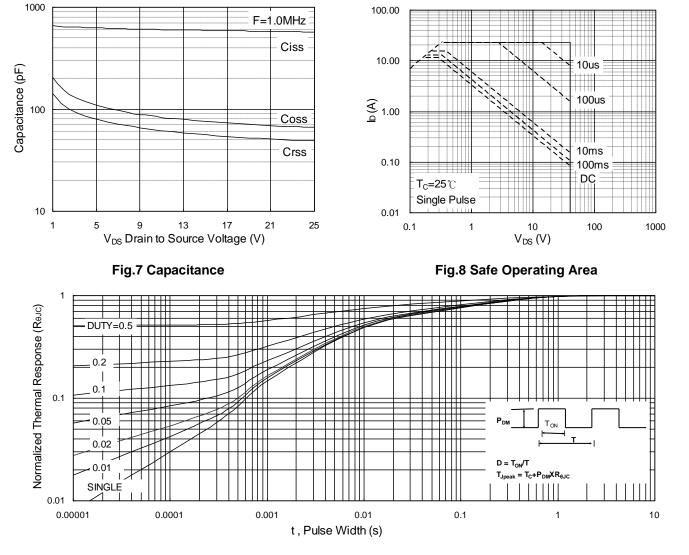
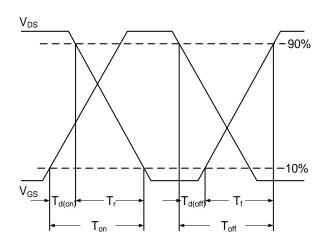
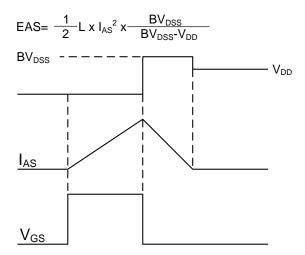


Fig.9 Normalized Maximum Transient Thermal Impedance



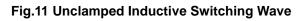




AO4614-MS HF 🐼

Compiance

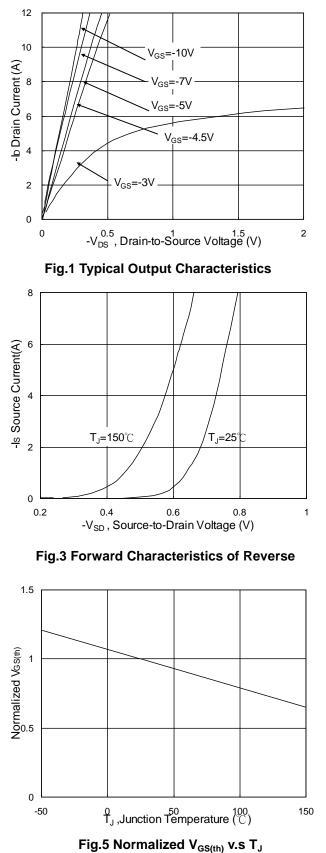
Semiconductor

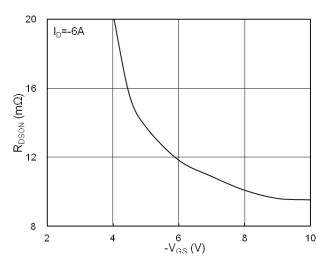






P-Channel Typical Characteristics







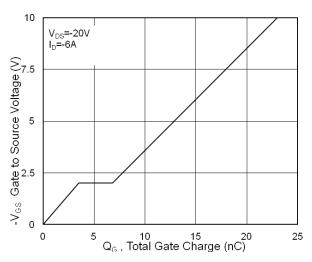
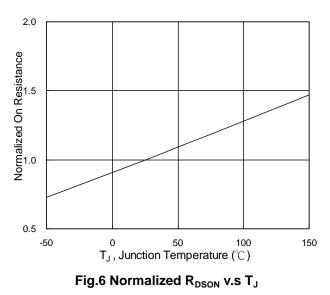


Fig.4 Gate-Charge Characteristics





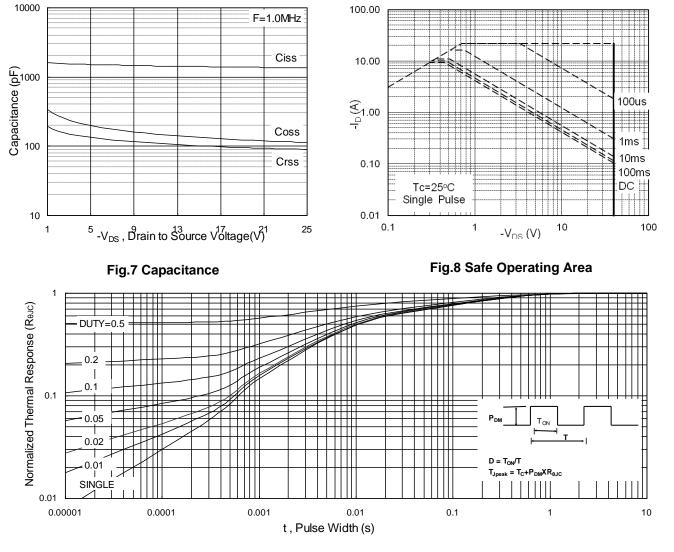
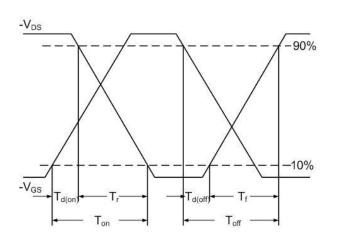
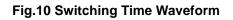
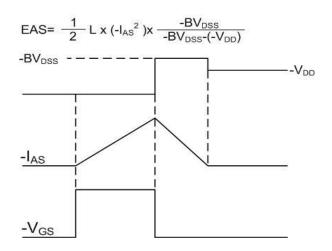


Fig.9 Normalized Maximum Transient Thermal Impedance







AO4614-MS HF 🐼

Compiance

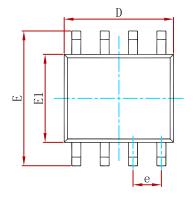
Semiconductor

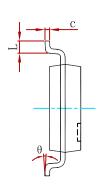


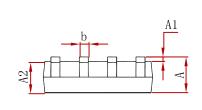


AO4614-MS Semiconductor

PACKAGE MECHANICAL DATA

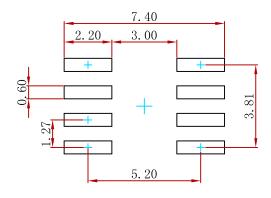






Symbol	Dimensions In Millimeters		Dimensions In Inches		
Symbol	Min	Max	Min	Max	
Α	1.350	1.750	0.053	0.069	
A1	0.100	0.250	0.004	0.010	
A2	1.350	1.550	0.053	0.061	
b	0.330	0.510	0.013	0.020	
с	0.170	0.250	0.007	0.010	
D	4.800	5.000	0.189	0.197	
e	1.270 (BSC)		0.050 (BSC)		
Е	5.800	6.200	0.228	0.244	
E1	3.800	4.000	0.150	0.157	
L	0.400	1.270	0.016	0.050	
θ	0 °	8°	0 °	8°	

Suggested Pad Layout



Note:

1.Controlling dimension:in millimeters.

2.General tolerance:± 0.05mm.

3. The pad layout is for reference purposes only.

REEL SPECIFICATION

P/N	PKG	QTY
AO4614-MS	SOP-8	3000



<u>Attention</u>

■ Any and all MSKSEMI Semiconductor products described or contained herein do not have specifications that can handle applications that require extremely high levels of reliability, such as life-support systems, aircraft's control systems, or other applications whose failure can be reasonably expected to result in serious physical and/or material damage. Consult with your MSKSEMI Semiconductor representative nearest you before using any MSKSEMI Semiconductor products described or contained herein in such applications.

■ MSKSEMI Semiconductor assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications f any and all MSKSEMI Semiconductor products described orcontained herein.

■ Specifications of any and all MSKSEMI Semiconductor products described or contained herein stipulate the performance, characteristics, and functions of the described products in the independent state, and are not guarantees of the performance, characteristics, and functions of the described products as mounted in the customer's products or equipment. To verify symptoms and states that cannot be evaluated in an independent device, the customer should always evaluate and test devices mounted in the customer's products or equipment.

■ MSKSEMI Semiconductor. strives to supply high-quality high-reliability products. However, any and all semiconductor products fail with someprobability. It is possible that these probabilistic failures could give rise to accidents or events that could endanger human lives, that could give rise to smoke or fire, or that could cause damage to other property. When designing equipment, adopt safety measures so that these kinds of accidents or events cannot occur. Such measures include but are not limited to protective circuits anderror prevention circuits for safedesign, redundant design, and structural design.

■ In the event that any or all MSKSEMI Semiconductor products (including technical data, services) described or contained herein are controlled under any of applicable local export control laws and regulations, such products must not be exported without obtaining the export license from theauthorities concerned in accordance with the above law.

■ No part of this publication may be reproduced or transmitted in any form or by any means, electronic or mechanical, including photocopying and recording, or any information storage or retrieval system, or otherwise, without the prior written permission of MSKSEMI Semiconductor.

■ Information (including circuit diagrams and circuit parameters) herein is for example only ; it is not guaranteed for volume production. MSKSEMI Semiconductor believes information herein is accurate and reliable, but no guarantees are made or implied regarding its use or any infringements of intellectual property rights or other rights of third parties.

Any and all information described or contained herein are subject to change without notice due to product/technology improvement, etc. Whendesigning equipment, referto the "Delivery Specification" for the MSKSEMI Semiconductor productthat you intend to use.

单击下面可查看定价,库存,交付和生命周期等信息

>>MSKSEMI (美森科)